

WHA YU INDUSTRIAL CO., LTD.(HEAD OFFICE) DONGGUAN AEON TECH CO.,LTD.(CHINA) SUZHOU AEON TECH CO.,LTD.(CHINA) M.gear AEON TECH (SHANGHAI) CO.,LTD.(CHINA)
DONGGUAN PARNER TECH CO.,LTD.(CHINA) DONGGUAN PARNER TECH CO.,LTD.(CHINA)

SPECIFICATION FOR APPROVAL

CUSTOMER: 中磊電子股份有限公司

PART NAME: PIFA Antenna Assembly

REVISION: *PART NO.:*

REV.: X1 W. Y. P/NO.: C147-510422-A(SSR-74152)

	MANUFACTURER SIGNATURE	CUSTOMER SIGNATURE
APPROVED BY:	(大) 東 () 唐間野講	
DATE :	12/3 用霜圖蘭 面顯毘業	

WHA YU GROUP

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PIFA Antenna Assembly

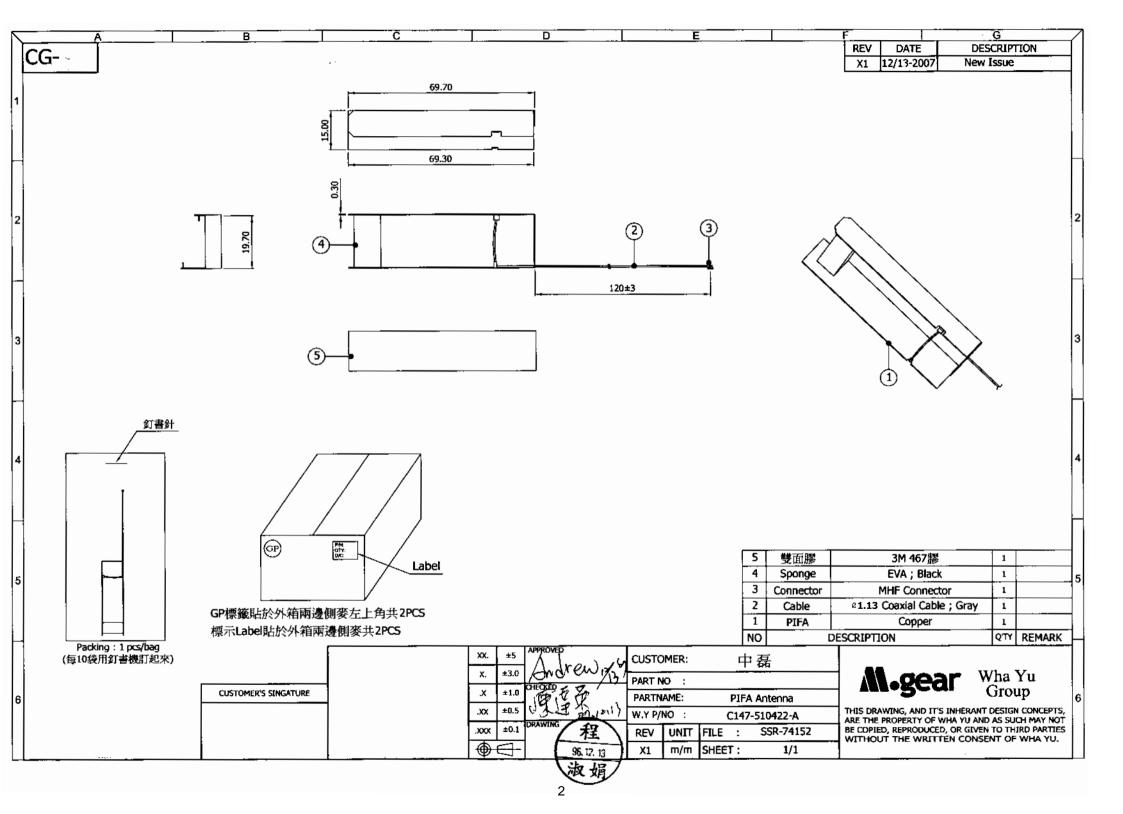
Specification

1. Electrical Properties:

- 1.1 Frequency Range.......868MHz ~ 908MHz
- 1.2 Impedance 50Ω Nominal
- 1.4 Return Loss.....-10 dB Max.
- 1.5 Efficiency......50%
- 1.6 Peak Gain......3.5dBi
- 1.7 Polarization.....Linear
- 1.8 Admitted Power..... 1W

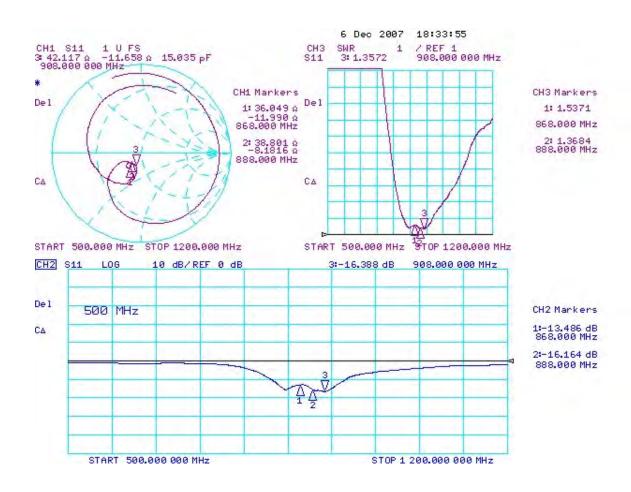
2. Physical Properties:

- 2.1 Cable..... ϕ 1.13mm Coaxial Cable
- 2.2 Operating Temp.- 20° C ~ +65 $^{\circ}$ C
- 2.3 Storage Temp. -30° C ~ $+75^{\circ}$ C
- 2.4 Connector......MHF(I-PEX)



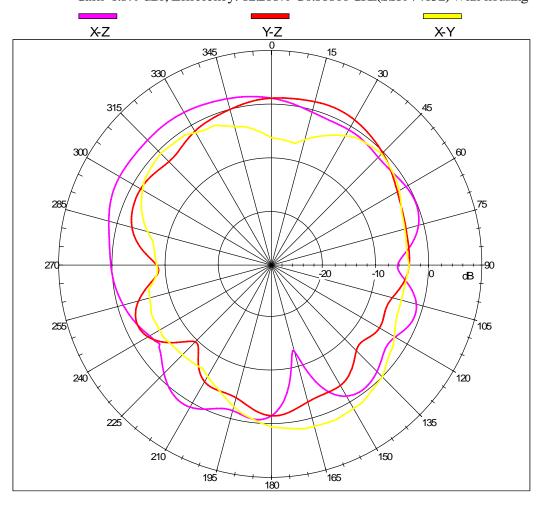


PIFA Antenna Assembly(With housing) 中磊C147-510422-A(SSR-74152)SPEC:868MHz~908MHz



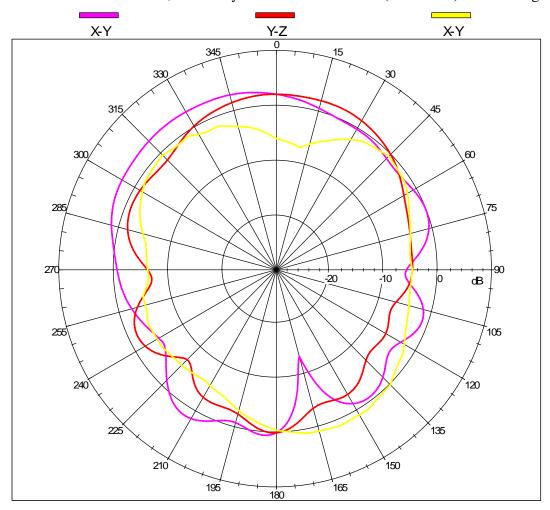
M.gear Wha Yu Group

Far-field Power Distribution on X-Z Plane(E-Plane of L3 Pol Sense) Gain=1.879 dBi; Efficiency: 82.268% @0.86800 GHz(SSR-74152) With housing



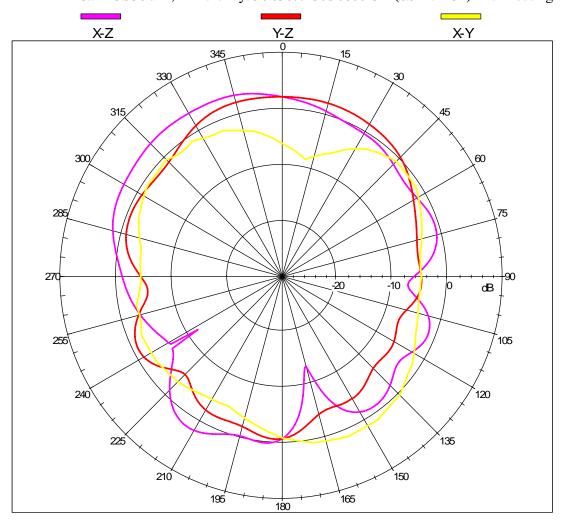
M.gear Wha Yu Group

Far-field Power Distribution on X-Z Plane(E-Plane of L3 Pol Sense) Gain=2.680 dBi; Efficiency: 96.403% @0.88800 GHz(SSR-74152) With housing



M.gear Wha Yu Group

Far-field Power Distribution on X-Z Plane(E-Plane of L3 Pol Sense) Gain=3.558 dBi; Efficiency: 90.050% @0.90800 GHz(SSR-74152) With housing



Date: 2005/02/02

Our Spec. No. WS05-M016

MESSRS.

SPECIFICATION

FOR

HIGH FREQUENCY COAXIAL CABLE

"KHCX - 32AWG - SB - TA* GRAY

SHOWA ELECTRIC WIRE & CABLE CO., LTD.

TORANOMON

TOKYO JAPAN

T. Mori

Manager, Engineering Section

J. mori

Engineering Dept. Electronic Wire Business Unit

1. 適用(SCOPE)

本仕様書は電子機器などの内部配線に使用される細径同軸 "KHCX-32AWG-SB-TA" の構造と特性につい

This specification covers the construction and characteristics of coaxial cable "KHCX-32AWG-SB-TA" for internal wiring of electronic equipment.

2. ケーブル型名の説明 (EXPLANATION OF CABLE TYPE)

 $\frac{\text{KHCX} - 32\text{AWG} - \text{SB} - \text{TA}}{(1) \quad (2) \quad (3) \quad (4)}$

- (1) ケーブル略称 (Cable Abbreviation)
- (2) 導体サイズ (Conductor Size)
- (3) Inner Conductor Type (4) Outer Conductor Type.

3. 構造(CONSTRUCTION)

I		要求特性
]	tem	Requirement
	材質	銀めっき軟銅線
	Material	Silver coated annealed copper wire
内部導体	構成	7/0.08mm
Inner conductor	Stranding	//U.U8mm
	外径	標準 0.24mm
	Diameter	Nom. 0.24mm
	材質	FEP
	Material	PEP
	色別	自然色
絶緣体	Color	Natural
Insulation	厚さ	標準 0.22mm
	Thickness	Nom. 0.22mm
	外径	0.68 +0.04/ -0.02mm
	Diameter	
	材質	錫めっき銅合金線編組
	Material	Tinned copper alloy wire braid shield
外部導体	構成	16/4/0.05 mm
Outer conductor	Stranding	100 D 0.00 Hill
	編組密度	A 000/
	Coverage	Approx. 90%
	材質	FEP
	Material	
シース	色別	灰・白・黒
Sheath	Color	Gray · White · Black
	厚さ	標準 0.10mm
J. f. El Ave	Thickness	Nom. 0.10mm
仕上外径		1.13mm +0.08/ -0.05mm
Overall diameter		
概算質量		3 kg/km
Approximate mass		

4. 特性 (CHARACTERISTICS)

項目	単位	要求特性
Item	Unit	Requirements
導体抵抗	Ω/km	597以下 (20℃)
Conductor Resistance	₹3/KIII	Max. 520 (at 20°C)
絶縁抵抗	MΩkm	1,500 以上(DC 500V 1 分間充電後,20℃)
Insulation Resistance	141 99 1/11	Min. 1,500 (After charge DC 500V for 1 min. at 20°C)
		絶縁体: AC.1.5kV/0.15 秒間(スパークテスト)
		Dielectric core: No breakdown at AC.1.5kV for 0.15sec by spark test.
耐電圧		シース:AC.1.5kV/0.15 秒間(スパークテスト)
Dielectric Strength	-	Jacket: No breakdown at AC.1.5kV for 0.15sec by spark test.
Dielectric Siterigin		内部導体-外部導体間:AC.500V/1 分間
		No breakdown at AC.500V for 1 min between outer conductor and
		inner conductor.
静電容量		標準 98 (at 1kHz)
Capacitance	pF/m	Nom. 98 (at 1kHz)
特性インピーダンス	Ω	50±2 (at TDR)
Characteristic Impedance	74	30±2 (at 1DR)
		2.0GHz: 2.9 以下 Max.2.9
		2.4GHz: 3.2以下 Max.3.2
減衰量	· · ·	3.0GHz: 3.7 以下 Max.3.7
Attenuation	dB/m	4.0GHz: 4.3 以下 Max.4.3
		5.0GHz: 4.8 以下 Max.4.8
		6.0GHz: 5.3 以下 Max.5.3
VSWR		2.4~2.5GHz:1.20以下 Max.1.20
		4.8~6.0GHz: 1.40 以下 Max.1.40
┃ 耐はんだ性		絶縁体およびシースの寸法変化は 0.2mm 以下のこと。
Heat resistance for		Shrink and expansion of dielectric core or jacket should not be more
solder		than 0.2mm.
SUIGG		試験条件(test condition): 255℃±5℃ * 3 sec.

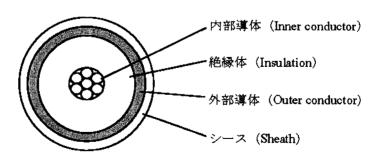


図1.ケーブル構造図

Fig.1. Cable Cross-Section



譁裕實業股份有限公司

WHA YU INDUSTRIAL CO., LTD

Connector 材質證明書

諸	萨裕料號 /hayu P/N	Z101-021	10002-A1		Pro	產品名称 duct Na	i me	MHF	Plug for φ 1.13 Coaxial Cable
	結構圖面								
(10) (10) (3) (2.4) (2.4) (3) (4) (5) (6) (7) (7) (7) (8) (9) (10) (1									
			材質成	份					表面處理
1	絕緣	PBT	Poly	ybutyler	ne Tere	phthalte	(UL 94V	-0)	Black
2	外殼	Phos. Bronze	Cu	Sn	P	Zn	Pb		鍍金 0.05 μ m
3	中心夾持	Phos. Bronze	Cu	Sn	P	Zn	Pb		鍍金 0.1 µ m
Ren	Remark:插拔次數 30 次 圖高問講 臺三崎師 田爾 圖爾								

SGS Test Report

Product : PIFA Antenna Assembly

Contents

No	Desc	ription	Report No.	Page	
1	Cable	φ 1.13mm Cable	CE/2007/C0427	P.12~16	
2	PIFA 洋白銅		CE/2007/11769	P.17~19	
3	Connector	MHF	CE/2007/46124	P.20~32	
			CE/2007/46148		
4	Sponge	EVA	GZ0703036357/CHEM	P.33~35	
5	雙面膠	3M 467 膠	CE/2006/72382B	P.36~40	

Result for RoHS: PASS



No.: CE/2007/C0427 Date: 2007/12/06 Page: 1 of 5

SWCC SHOWA DEVICE TECHNOLOGY CO., LTD.
NO. 1-8, TORANOMON 1-CHOME, MINATO-KU, TOKYO 105-8444

The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description : ANTENNA COAXIAL CABLE UL-STYLE 11032

Style/Item No. : FOR KHCX-30AWG-SB-TA / KHCX-32AWG-SB-TA /

KHCX-36AWG-SB-TA / KHCX-32AWG-WSB-TA GRAY

Sample Receiving Date : 2007/12/03

Testing Period : 2007/12/03 TO 2007/12/06

Test Requested : In accordance with the RoHS Directive 2002/95/EC, and its

amendment directives.

Test Method : With reference to IEC 62321, Ed.1 111/54/CDV

Procedures for the Determination of Levels of Regulated

Substances in Electrotechnical Products.

(1) Determination of Cadmium by ICP-AES.

(2) Determination of Lead by ICP-AES.

(3) Determination of Mercury by ICP-AES.

(4) Determination of Hexavalent Chromium for non-metallic

samples by UV/Vis Spectrometry.

(5) Determination of Hexavalent Chromium for metallic

samples by Spot test / Colorimetric Method.

(6) Determination of PBB and PBDE by GC/MS.

Test Result(s) : Please refer to next page(s).

Chenyu Kung / Operation Manager

Signed for and on behalf of SGS TAIWAN LTD.

Chemical Laboratory - Taipei



No.: CE/2007/C0427 Date: 2007/12/06 Page : 2 of 5

SWCC SHOWA DEVICE TECHNOLOGY CO., LTD. NO. 1-8, TORANOMON 1-CHOME, MINATO-KU, TOKYO 105-8444



Test results by chemical method (Unit: mg/kg)

	Method	Result				100
Test Item (s):	(Refer to)	No.1	No.2	No.3	No.4	MDL
Cadmium (Cd)	(1)	n.d.	n.d.	n.d.	n.d.	2
Lead (Pb)	(2)	n.d.	n.d.	n.d.	n.d.	2
Mercury (Hg)	(3)	n.d.	n.d.	n.d.	n.d.	2
Hexavalent Chromium Cr(VI) by alkaline extraction	(4)	n.d.	n.d.		222	2
Hexavalent Chromium Cr(VI) by Spot test / boiling water extraction	(5)			Negative	Negative	See Note 5
Sum of PBBs		n.d.	n.d.	-	222	2
Monobromobiphenyl		n.d.	n.d.			5
Dibromobiphenyl		n.d.	n.d.	22	3.2	5
Tribromobiphenyl		n.d.	n.d.	7		5
Tetrabromobiphenyl		n.d.	n.d.		2.0	5
Pentabromobiphenyl		n.d.	n.d.		244	5
Hexabromobiphenyl		n.d.	n.d.	5		5
Heptabromobiphenyl		n.d.	n.d.		mas - 5	5
Octabromobiphenyl		n.d.	n.d.	-	- 	5
Nonabromobiphenyl		n.d.	n.d.			5
Decabromobiphenyl		n.d.	n.d.		1-2-	5
Sum of PBDEs (Mono to Nona) (Note 4)	(6)	n.d.	n.d.		1544	1
Monobromobiphenyl ether		n.d.	n.d.			5
Dibromobiphenyl ether		n.d.	n.d.		-322	5
Tribromobiphenyl ether		n.d.	n.d.	-	1000	5
Tetrabromobiphenyl ether		n.d.	n.d.	()	24	5
Pentabromobiphenyl ether		n.d.	n.d.	-	74-	5
Hexabromobiphenyl ether		n.d.	n.d.	4-0		5
Heptabromobiphenyl ether		n.d.	n.d.	-	(m ent) z j	5
Octabromobiphenyl ether		n.d.	n.d.			5
Nonabromobiphenyl ether		n.d.	n.d.		7 (10 f) = 1	5
Decabromobiphenyl ether		n.d.	n.d.	- 200	Care 1	5
Sum of PBDEs (Mono to Deca)		n.d.	n.d.	- 44		-



No.: CE/2007/C0427 Date: 2007/12/06

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SWCC SHOWA DEVICE TECHNOLOGY CO., LTD. NO. 1-8, TORANOMON 1-CHOME, MINATO-KU, TOKYO 105-8444



TEST PART DESCRIPTION:

GRAY PLASTIC JACKET NO.1 NO.2 TRANSPARENT PLASTIC

NO.3 SILVER COLORED METAL WIRE NO.4 SILVER COLORED METAL FOIL

Note: 1. mg/kg = ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit

4. According to 2005/717/EC DecaBDE is exempt.

5. Spot-test:

Negative = Absence of Cr(VI) coating / surface layer, Positive = Presence of Cr(VI) coating / surface layer;

(The tested sample should be further verified by boiling-water-extraction method if the spot test result cannot be confirmed.)

Boiling-water-extraction:

Negative = Absence of Cr(VI) coating / surface layer. Positive = Presence of Cr(VI) coating / surface layer; the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm² sample surface area.

6. "-" = Not Regulated

7. "---" = Not Conducted



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SWCC SHOWA DEVICE TECHNOLOGY CO., LTD. NO. 1-8, TORANOMON 1-CHOME, MINATO-KU, TOKYO 105-8444







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No.: CE/2007/C0427 Date: 2007/12/06 Page : 5 of 5

SWCC SHOWA DEVICE TECHNOLOGY CO., LTD. NO. 1-8, TORANOMON 1-CHOME, MINATO-KU, TOKYO 105-8444







** End of Report **

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測試報告

號碼: CE/2007/11769 日期: 2007/01/15 頁數: 1 of 3

青棋五金有限公司 PRO BRASS METAL CO., LTD. 以下測試樣品係由客户送樣, 且由客户聲稱並經客户確認如下(The following sample(s) was/were submitted and identified by/on behalf of the client as):

樣品名稱

: 洋白板

Sample Description

: NICKEL SILVER

樣品型號(Style/Item No.)

C7701

收件日期(Sample Receiving Date)

2007/1/8

測試期間(Testing Period)

2007/1/8

TO 2007/01/15

測試需求 / Test Requested

測試方法 / Test Method

- : 参考IEC 62321, Ed. 1 111/54/CDV方法檢測./ With reference to IEC 62321, Ed.1 111/54/CDV. Procedures for the Determination of Levels of Regulated Substances in Electrotechnical Products.
 - (1) 用感應藕合電漿原子發射光譜儀檢測鎬含量 / Determination of Cadmium by ICP-AES.
 - (2) 用感應藕合電漿原子發射光譜儀檢測鉛含量 / Determination of Lead by ICP-AES
 - (3) 用感應藕合電漿原子發射光譜儀檢測汞含量. / Determination of Mercury by ICP-AES
 - (4) 針對金屬材質之樣品,用Spot test / Colorimetric方法檢測六價 鉻含量. / Determination of Hexavalent Chromium for metallic samples by Spot test / Colorimetric Method.

測試結果 / Test Result(s)

: 請見下一頁.

Daniel Yeh, M.R. Operation Manager Signed for and on behalf of

SGS TAIWAN LTD.



測試報告

號碼: CE/2007/11769 日期: 2007/01/15 頁數: 2 of 3

青棋五金有限公司 PRO BRASS METAL CO., LTD.



測試結果 (單位: mg/kg) / Test Result(s)

測試項目 /	測試方法 Method	結果 / Result	方法偵測 極限値
Test Item (s):	(Refer to)	No.1	(MDL)
鎬 / Cadmium (Cd)	(1)	n.d.	2
鉛 / Lead (Pb)	(2)	22.8	2
汞 / Mercury (Hg)	(3)	n.d.	2
六價鉻 / Hexavalent Chromium Cr(VI)	(4)	Negative	See Note 4
by Spot test / boiling water			

測試部位描述 / TEST PART DESCRIPTION:

NO.1 : 銀色金屬 / SILVER COLORED METAL

Note: 1. mg/kg = ppm

2. n.d. = Not Detected / 未檢出

3. MDL = Method Detection Limit / 方法偵測極限値

4. Spot-test:

Negative = Absence of CrVI coating / surface layer,

Positive = Presence of CrVI coating / surface layer;

(The tested sample should be further verified by boiling-water-extraction method if the spot test result cannot be confirmed.)

Negative=鍍層中偵測不到六價鉻, Positive= 鍍層中偵測到六價鉻;

當該測項無法確認時,測試樣品可藉由boiling-water-extraction測試方法進一步確認

Boiling-water-extraction:

Negative = Absence of CrVI coating / surface layer,

Positive = Presence of CrVI coating / surface layer; the detected concentration in

boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 ${\rm cm}^2$ sample surface area.

Negative=鍍層中偵測不到六價鉻, Positive=鍍層中偵測到六價鉻;

該濃度溶液≧0.02 mg/kg with 50 cm² (sample surface area)



測試報告

號碼 : CE/2007/11769 日期 : 2007/01/15 頁數: 3 of 3

青棋五金有限公司 PRO BRASS METAL CO., LTD.





報告結尾 **



I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN No. : CE/2007/46149 Date : 2007/05/02

Page : 1 of 4

The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Description : MHF PLUG GROUND CONTACT

Style/Item No. : 1927-231 Sample Receiving Date : 2007/04/25

Testing Period : 2007/04/25 TO 2007/05/02

Test Result(s): Please refer to next page(s).

Daniel Yeh, M.R. Operation Manager

Signed for and on behalf of SGS TAIWAN LTD.



I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN No. : CE/2007/46149 Date : 2007/05/02

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Test Result(s)

GOLDEN COLORED METAL PART NAME NO.1

Test Item (s):	Unit	Method	MDL	Result
rest item (s).	Offic	Metriod	MIDL	No.1
Cadmium (Cd)	mg/kg	With reference to IEC 62321, Ed.1 111/54/CDV. Determination of Cadmium by ICP-AES.	2	n.d.
Lead (Pb)	mg/kg	With reference to IEC 62321, Ed.1 111/54/CDV. Determination of Lead by ICP-AES.	2	11
Mercury (Hg)	mg/kg	With reference to IEC 62321, Ed.1 111/54/CDV. Determination of Mercury by ICP-AES.	2	n.d.
Hexavalent Chromium Cr(VI) by alkaline extraction	mg/kg	With reference to IEC 62321, Ed.1 111/54/CDV. Determination of Hexavalent Chromium by UV/Vis Spectrometry.	2	n.d.
Copper (Cu)	%	With reference to US EPA Method 3050B for Copper Content. Analysis was performed by ICP-AES.	0.0002	91.845
Gold (Au)	mg/kg	With reference to US EPA Method 3050B for Gold Content. Analysis was performed by ICP-AES.	2	2305
Nickel (Ni)	%	With reference to US EPA Method 3050B for Nickel Content. Analysis was performed by ICP- AES.	0.0002	3.005

Note: 1. mg/kg = ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit



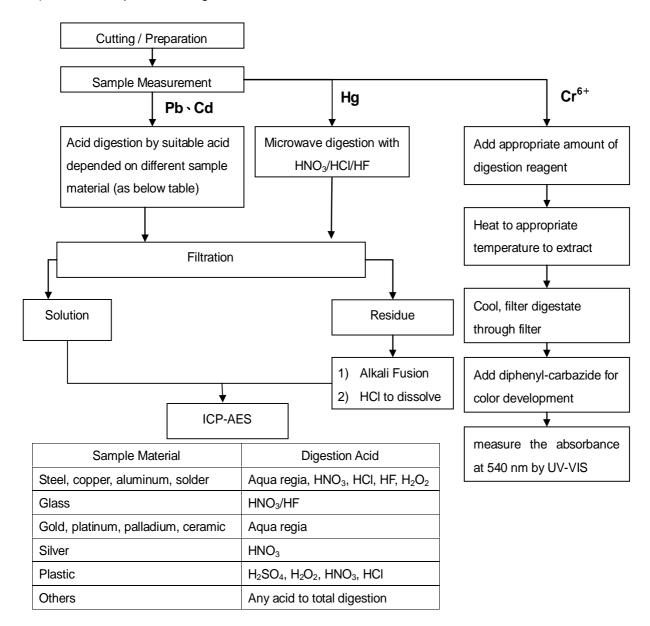
I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN No. : CE/2007/46149

Date : 2007/05/02

Page : 3 of 4

1) These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr6+ test method excluded)

- 2) Name of the person who made measurement: Troy Chang
- 3) Name of the person in charge of measurement: Daniel Yeh





I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN

No. : CE/2007/46149

Date : 2007/05/02 Page : 4 of 4



** End of Report **



No.: CE/2007/46124 Date: 2007/04/30

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I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN

The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Description

MHF PLUG HOUSING

Style/Item No.

: 1844-011

Sample Receiving Date

2007/04/25

Testing Period

2007/04/25 TO 2007/04/30

Test Requested

In accordance with the RoHS Directive 2002/95/EC, and its

amendment directives.

Test Method

With reference to IEC 62321, Ed.1 111/54/CDV

Procedures for the Determination of Levels of Regulated

Substances in Electrotechnical Products.

(1) Determination of Cadmium by ICP-AES.

(2) Determination of Lead by ICP-AES.

(3) Determination of Mercury by ICP-AES.

(4) Determination of Hexavalent Chromium for non-metallic

samples by UV/Vis Spectrometry.

(5) Determination of PBB and PBDE by GC/MS.

Test Result(s)

:

Please refer to next page(s).

Daniel Yen, M.R. / Operation Manager Signed for and on behalf of

SGS TAIWAN LTD.



No.: CE/2007/46124 Date: 2007/04/30 Page : 2 of 5

I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN



Test results by chemical method (Unit: mg/kg)

Test Home (a)	Method	Result	MDI
Test Item (s):	(Refer to)	No.1	MDL
Cadmium (Cd)	(1)	n.d.	2
Lead (Pb)	(2)	23	2
Mercury (Hg)	(3)	n.d.	2
Hexavalent Chromium Cr(VI) by alkaline extraction	(4)	n.d.	2
Sum of PBBs		n.d.	-
Monobromobiphenyl		n.d.	5
Dibromobiphenyl		n.d.	5
Tribromobiphenyl		n.d.	5
Tetrabromobiphenyl		n.d.	5
Pentabromobiphenyl		n.d.	5
Hexabromobiphenyl		n.d.	5
Heptabromobiphenyl		n.d.	5
Octabromobiphenyl		n.d.	5
Nonabromobiphenyl		n.d.	5
Decabromobiphenyl		n.d.	5
Sum of PBDEs (Mono to Nona) (Note 4)	(5)	n.d.	-
Monobromobiphenyl ether		n.d.	5
Dibromobiphenyl ether		n.d.	5
Tribromobiphenyl ether		n.d.	5
Tetrabromobiphenyl ether		n.d.	5
Pentabromobiphenyl ether		n.d.	5
Hexabromobiphenyl ether		n.d.	5
Heptabromobiphenyl ether		n.d.	5
Octabromobiphenyl ether		n.d.	5
Nonabromobiphenyl ether		n.d.	5
Decabromobiphenyl ether		n.d.	5
Sum of PBDEs (Mono to Deca)		n.d.	-

TEST PART DESCRIPTION:

BLACK PLASTIC NO.1

Note: 1. mg/kg = ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit

4. According to 2005/717/EC DecaBDE is exempt.

5. "-" = Not Regulated

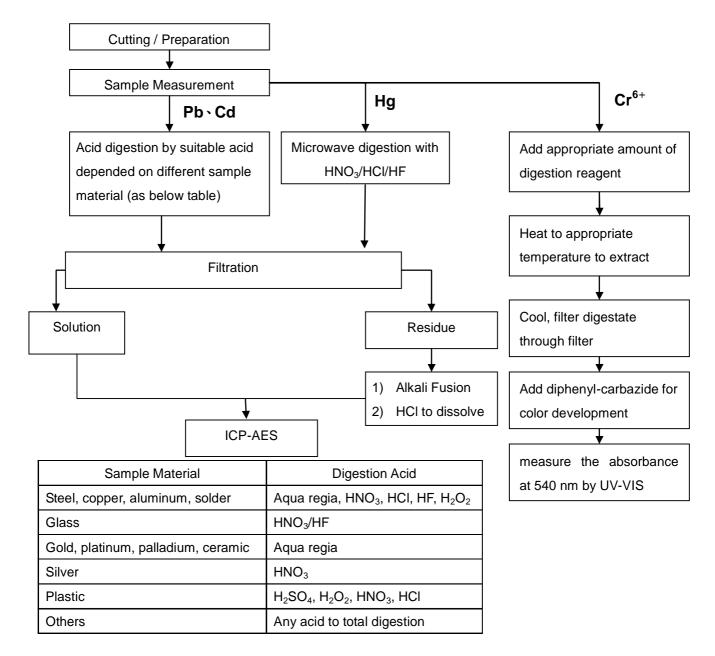
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I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN

- These samples were dissolved totally by pre-conditioning method according to below flow chart.
 (Cr6+ test method excluded)
- 2) Name of the person who made measurement: Troy Chang
- 3) Name of the person in charge of measurement: Daniel Yeh



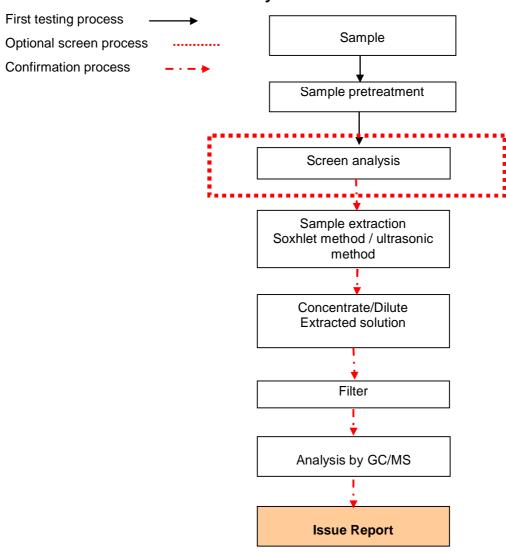


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I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN



PBB/PBDE analytical FLOW CHART





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I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN





** End of Report **



I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN No. : CE/2007/46148 Date : 2007/05/02

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The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Description MHF PLUG CONTACT

Style/Item No. 1845-011 Sample Receiving Date 2007/04/25

Testing Period 2007/04/25 TO 2007/05/02

Test Result(s) Please refer to next page(s).

Operation Manager gned for and on behalf of

SGS TAIWAN LTD.



I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN No. : CE/2007/46148 Date : 2007/05/02

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Test Result(s)

GOLDEN COLORED METAL PART NAME NO.1

Test Item (s):	Unit	Method	MDL	Result
rest item (s).	Offic	WetHod	MIDL	No.1
Cadmium (Cd)	mg/kg	With reference to IEC 62321, Ed.1 111/54/CDV. Determination of Cadmium by ICP-AES.	2	n.d.
Lead (Pb)	mg/kg	With reference to IEC 62321, Ed.1 111/54/CDV. Determination of Lead by ICP-AES.	2	16
Mercury (Hg)	mg/kg	With reference to IEC 62321, Ed.1 111/54/CDV. Determination of Mercury by ICP-AES.	2	n.d.
Hexavalent Chromium Cr(VI) by alkaline extraction	mg/kg	With reference to IEC 62321, Ed.1 111/54/CDV. Determination of Hexavalent Chromium by UV/Vis Spectrometry.	2	n.d.
Copper (Cu)	%	With reference to US EPA Method 3050B for Copper Content. Analysis was performed by ICP-AES.	0.0002	90.56
Gold (Au)	mg/kg	With reference to US EPA Method 3050B for Gold Content. Analysis was performed by ICP-AES.	2	3320
Nickel (Ni)	%	With reference to US EPA Method 3050B for Nickel Content. Analysis was performed by ICP-AES.	0.0002	3.525

Note: 1. mg/kg = ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit



I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN No. : CE/2007/46148

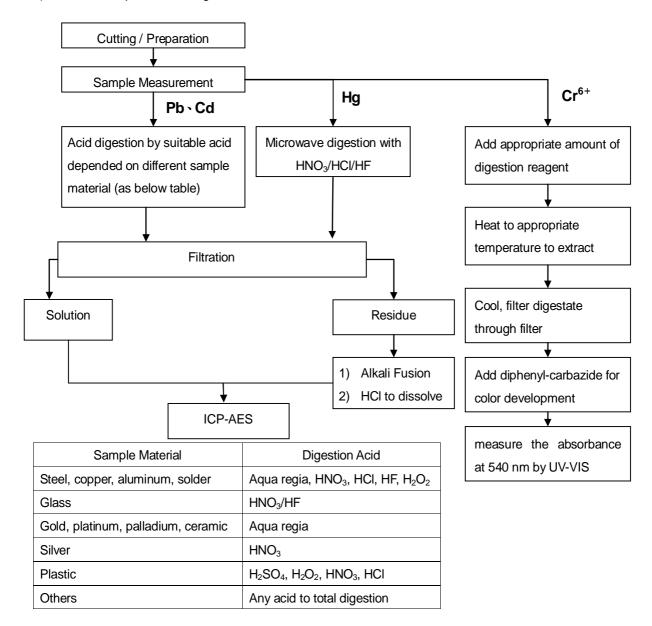
Date : 2007/05/02

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1) These samples were dissolved totally by pre-conditioning method according to below flow chart.

(Cr6+ test method excluded)

- 2) Name of the person who made measurement: Troy Chang
- 3) Name of the person in charge of measurement: Daniel Yeh





I-PEX JP CO., LTD. 6-27-19 HARAMACHIDA MACHIDA-CITY TOKYO 194-0013 JAPAN

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** End of Report **





No.: GZ0703036357/CHEM

Date: MAR 22, 2007

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DONG GUAN CITY DAO JIAO YUXIN SHOES MATERIAL FACTORY YUAN JIANG ROAD, BAI LU VILLAGE, CAI BAI MANAGEMENT AREA, DAOJIAO TOWN, DONG GUAN CITY OF GUANG DONG

The following sample(s) was/were submitted and identified on behalf of the applicant as 黑 EVA

SGS Ref No.

: SZ10294148-2.1

Sample Receiving Date

: MAR 16, 2007

Testing Period

: MAR 16, 2007 TO MAR 22, 2007

Test Requested

: To determine the Cadmium, Lead, Mercury, Hexavalent Chromium, PBBs (Polybrominated Biphenyls) & PBDEs (Polybrominated Diphenylethers) content in the submitted sample.

Test Method

: With reference to IEC 62321 Ed.1 111/54/CDV

Procedures for the Determination of Levels of Regulated Substances in Electrotechnical Products

- (1) Determination of Cadmium by ICP.
- (2) Determination of Lead by ICP.
- (3) Determination of Mercury by ICP.
- (4) Determination of Hexavalent Chromium by Colorimetric Method.

(5) Determination of PBBs and PBDEs by GC-MS.

Test Results

: Please refer to next page.

Signed for and on behalf of SGS-CSTC Ltd.

Huang Fang, Sunny

Sr. Engineer